## Notice of References Cited Application/Control No. O9/848,539 Examiner Phuoc H. Nguyen Applicant(s)/Patent Under Reexamination HEPPE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,201,797 B1	03-2001	Leuca et al.	370/316
	В	US-6,760,757 B1	07-2004	Lundberg et al.	709/217
	C	US-6,449,287 B1	09-2002	Leuca et al.	370/468
	D	US-5,950,129 A	09-1999	Schmid et al.	455/431
	Ε	US-6,438,468 B1	08-2002	Muxlow et al.	701/3
	F	US-6,757,712 B1	06-2004	Bastian et al.	709/206
	G	US-6,760,778 B1	07-2004	Nelson et al.	709/246
	н	US-6,785,712 B1	08-2004	Hogan et al.	709/206
	1	US-6,421,727 B1	07-2002	Reifer et al.	709/225
	J	US-6,732,027 B2	05-2004	Betters et al.	701/29
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Ρ					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	х	

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